



KP2000A/5000V

HIGH POWER THYRISTOR FOR PHASE CONTROL APPLICATIONS

Features:

- . All Diffused Structure
- . Spoke Amplifying Gate Configuration
- . High dV/dt Capability
- . Pressure Assembled Device

ELECTRICAL CHARACTERISTICS AND RATINGS

Blocking - Off State

Device Type	V_{RRM} (1)	V_{DRM} (1)	V_{RSM} (1)
KP2000A	5000	5000	5200

V_{RRM} = Repetitive peak reverse voltage

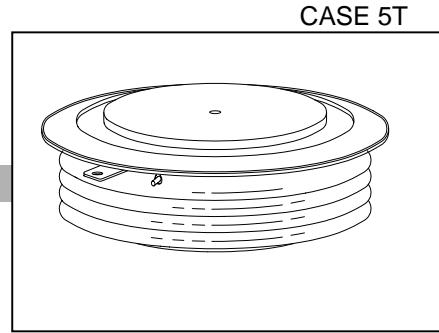
V_{DRM} = Repetitive peak off state voltage

V_{RSM} = Non repetitive peak reverse voltage (2)

Repetitive peak reverse leakage and off state leakage	I_{RRM} / I_{DRM}	10 mA 200 mA (3)
Critical rate of voltage rise	dV/dt (4)	1000 V/ μ sec

Conducting - on state

Parameter	Symbol	Min.	Max.	Typ.	Units	Conditions
Average value of on-state current	$I_{T(AV)}$		2000		A	Sinewave, 180° conduction, $T_c=70^\circ C$
RMS value of on-state current	I_{TRMS}		4000		A	Nominal value
Peak one cpstle surge (non repetitive) current	I_{TSM}		40000 36000		A A	8.3 msec (60Hz), sinusoidal wave- shape, 180° conduction, $T_j = 125^\circ C$ 10.0 msec (50Hz), sinusoidal wave- shape, 180° conduction, $T_j = 125^\circ C$
I^2t	I^2t		10×10^6		A^2s	8.3 msec and 10.0 msec
Latching current	I_L		1500		mA	$V_D = 24 V; R_L = 12 \text{ ohms}$
Holding current	I_H		250		mA	$V_D = 24 V; I = 2.5 A$
Peak on-state voltage	V_{TM}		2.40		V	$I_{TM} = 5000 A$
Critical rate of rise of on-state current (5)	di/dt		300		$A/\mu s$	Switching from $V_{DRM} \leq 800 V$, non-repetitive
Critical rate of rise of on-state current	di/dt		100		$A/\mu s$	Switching from $V_{DRM} \leq 800 V$



Notes:

All ratings are specified for $T_j=25^\circ C$ unless otherwise stated.

(1) All voltage ratings are specified for an applied 50Hz/60Hz sinusoidal waveform over the temperature range -40 to +125 °C.

(2) 10 msec. max. pulse width

(3) Maximum value for $T_j = 125^\circ C$.

(4) Minimum value for linear and exponential waveshape to 70% rated V_{DRM} . Gate open. $T_j = 125^\circ C$.

(5) Non-repetitive value.

KP2000A/5000V

Gating

Parameter	Symbol	Min.	Max.	Typ.	Units	Conditions
Peak gate power dissipation	P _{GM}		200		W	t _p = 40 us
Average gate power dissipation	P _{G(AV)}		5		W	
Peak gate current	I _{GM}		20		A	
Gate current	I _{GT}		300		mA	
Gate voltage	V _{GT}	0.30	3.5		V	

Dynamic

Parameter	Symbol	Min.	Max.	Typ.	Units	Conditions
Delay time	t _d				μs	
Turn-off time (with V _R = -50 V)	t _q				μs	

THERMAL AND MECHANICAL CHARACTERISTICS AND RATINGS

Parameter	Symbol	Min.	Max.	Typ.	Units	Conditions
Operating temperature	T _j	-40	+125		°C	
Storage temperature	T _{stg}	-40	+150		°C	
Thermal resistance - junction to case	R _{θ(j-c)}		0.012		°C/W	Double sided cooled Single sided cooled
Thermal resistamce - case to sink	R _{θ(c-s)}		0.002		°C/W	Double sided cooled * Single sided cooled *
Mounting force	P	8000	10000		lb. kN	
Weight	W				Lb. Kg.	

* Mounting surfaces smooth, flat and greased

Note : for case outline and dimensions, see case outline drawing

